

DOI: 10.32604/ee.2023.045204

# ARTICLE





# Fault Monitoring Strategy for PV System Based on I-V Feature Library

Huaxing Zhao<sup>1</sup>, Yanbo Che<sup>1,\*</sup>, Gang Wen<sup>2</sup> and Yijing Chen<sup>3</sup>

<sup>1</sup>School of Electrical and Information Engineering, Tianjin University, Tianjin, 300000, China

<sup>2</sup>State Grid Shuozhou Electric Power Supply Company, Shuozhou, 036000, China

<sup>3</sup>China Huaneng Clean Energy Research Institute Technology Co., Ltd., Beijing, 102209, China

\*Corresponding Author: Yanbo Che. Email: ybche@tju.edu.cn

Received: 20 August 2023 Accepted: 02 November 2023 Published: 27 February 2024

# ABSTRACT

Long-term use in challenging natural conditions is possible for photovoltaic modules, which are extremely prone to failure. Failure to diagnose and address faults in Photovoltaic (PV) power systems in a timely manner can cause permanent damage to PV modules and, in more serious cases, fires. Therefore, research into photovoltaic module defect detection techniques is crucial for the growth of the photovoltaic sector as well as for maintaining national economic prosperity and ensuring public safety. Considering the drawbacks of the current real-time and historical data-based methods for monitoring distributed PV systems, this paper proposes a method for monitoring PV systems at the module or string level that can be achieved by monitoring only electrical signals. The approach doesn't need a lot of tests to get the operational data of PV modules beforehand and only requires theoretical feature libraries of PV modules through panel parameter calculations. The present operating conditions and the open-circuit and short-circuit faults can be precisely identified by comparing the observed open-circuit voltage and short-circuit current with the corresponding data in the theoretical feature library. After that, by comparing the measured maximum power point voltage and current with the corresponding data in the theoretical feature library through the threshold method, aging and shadowing faults can be accurately determined. Experimental testing was done to see whether the suggested method was effective. The results show that the proposed technique is able to diagnose open-circuit faults, short-circuit faults, aging faults, and shadowing faults with shadow occlusion above 20%.

# **KEYWORDS**

PV system; lambert W function; threshold method

# 1 Introduction

In order to prevent yield losses and extend the amortization period of solar systems with high initial installation costs, fault-free operation of photovoltaic systems is crucial [1]. Distributed PV has developed rapidly in recent years, and has become the main force of the current world's new installed PV capacity. In China, for example, according to the National Energy Administration, the installed capacity of distributed PV reached 108 million kilowatts in 2021, accounting for about one-third of all installed PV capacity on the grid. Distributed PV added about 29.279 million kilowatts, accounting for about 55% of all new installed PV power generation and breaking 50% for the very first time in history.



This work is licensed under a Creative Commons Attribution 4.0 International License, which permits unrestricted use, distribution, and reproduction in any medium, provided the original work is properly cited.

Long-term use in hostile conditions makes photovoltaic modules more prone to failure. Failure to identify and fix problems with PV power systems in a timely way can result in fires and irreversible damage to PV modules. Therefore, research into solar module defect detection techniques is crucial for the growth of the photovoltaic sector as well as for maintaining national economic prosperity and ensuring public safety.

To correctly identify the errors that arise in PV systems, many monitoring and troubleshooting methods have been studied in the literature, which vary in terms of speed, complexity, and sensor requirements, as well as the ability to identify a large number of faults [2,3]. There are three types of PV defect detection techniques: optical, thermal, and electrical [4]. Fault detection based on optical and thermal methods is expensive in terms of equipment, which limits the versatility of this method. The electrical approach has become the most widely applied fault monitoring method due to its low equipment cost and easy data acquisition. Electrical methods analyze the operating conditions by monitoring the electrical parameters of the PV system, which are mainly divided into two methods based on historical data and real-time data.

Methods based on historical data include statistical analysis and artificial intelligence algorithm monitoring methods. The statistical analysis method sets reasonable fault alarm trigger thresholds by analyzing historical data. Artificial intelligence algorithms have also been widely used for troubleshooting. Indeed, artificial intelligence algorithms have been widely applied to analyze the current operating conditions through historical data. For example, in references [5,6], the extreme learning machine algorithm was used, and different neural network algorithms were employed in references [7,8]. These methods leverage the power of artificial intelligence to accurately predict and analyze the performance of photovoltaic systems in real-time. The method based on historical data records. However, with the rapid development of distributed photovoltaic systems, there are significant differences in installed capacity and a wide variety of component models and interconnection methods. Thus, it is difficult to obtain complete historical data for various distributed photovoltaic systems, making it challenging to predict the operational status of the systems.

To address the limitations of the historical data-based methods, scholars have developed an approach based on real-time data. The real-time data-based approach generally determines the presence of faults by monitoring the differences between the electrical parameters of operating PV modules, strings, and arrays and the simulation results. In references [9-11], the photovoltaic module power generation was primarily predicted using environmental parameters and photovoltaic array parameters. A comparison is then made with the real-time system power generation to enable monitoring of the photovoltaic system. Reference [12] monitored large photovoltaic power plants in Thailand by monitoring the GT value of photovoltaic systems. The monitoring system mentioned above requires continuous monitoring of various parameters and real-time computations, which can be costly. Therefore, some scholars have proposed fault monitoring methods that only require analyzing the operating condition of photovoltaic systems based on fixed-time measurements. In reference [13], an online fault monitoring method was proposed which monitors open, short, and partial faults by operating voltage and ambient temperature. Reference [14] built upon the foundation of reference [13] by incorporating irradiance monitoring. In references [15,16], on the other hand, introduced current monitoring by utilizing four characteristic parameters: temperature, irradiance, current, and voltage. This expanded monitoring approach allows the detection of four types of faults: open-circuit faults, short-circuit faults, shading faults, and aging faults. While increasing the monitoring of environmental parameters can enhance monitoring accuracy, it also simultaneously increases monitoring costs and inherent errors. Environmental sensors can only monitor environmental values and cannot accurately

acquire the temperature and irradiance on the PV modules, thus introducing errors. In addition, for small and widely distributed PV systems, it is even more difficult to ensure monitoring accuracy with only a small number of environmental sensors. Therefore, in reference [17], a monitoring method was proposed that does not require monitoring irradiance but can still detect four typical faults. Although the improvements were made in reference [17], it still utilizes temperature as an environmental variable. It is challenging to accurately obtain the actual temperatures of each component in distributed photovoltaic systems operating under highly complex conditions. Since electrical parameters such as current and voltage are directly obtained from the photovoltaic modules with high precision, proposing a monitoring method that eliminates the need for environmental variables and only requires electrical variables could significantly enhance monitoring accuracy and reduce monitoring system costs.

Considering the limitations of various monitoring methods currently applied to distributed photovoltaic systems, this paper proposes a novel real-time data-based monitoring method. This approach enables the monitoring of module or string-level photovoltaic systems solely through the analysis of electrical signals. In contrast to other methods, this approach only requires monitoring the open-circuit voltage, short-circuit current, and voltage and current at the maximum power point, without the need for environmental parameter monitoring. A comparison between this study and other methods based on real-time data is shown in Table 1.

Types of faults	Required monitoring data	Authors
Damaged bypass diode and shadowing fault	Temperature, current and voltage	Ko et al. [9]
Shadowing fault	Current and voltage	Bressan et al. [10]
Power loss	Irradiance, temperature, current and voltage	Leva et al. [11]
Short-circuit, open-circuit and shadowing faults	Temperature and voltage	Gokmen et al. [13]
Power loss	Irradiance, temperature, current and voltage	Forero et al. [14]
Short-circuit fault	Irradiance, temperature, current and voltage	Silvestre et al. [15]
Short-circuit, open-circuit, shadowing and aging faults	Irradiance, current and voltage	Pei et al. [17]
Short-circuit, open-circuit, shadowing and bypass diode faults	Irradiance, temperature, current and voltage	Aljafari et al. [16]
Short-circuit, open-circuit, shadowing and aging faults	Current and voltage	Authors of this article

Table 1: Comparison between this study and other methods based on real-time data

#### **2** Fault Monitoring Theory

The PV module output characteristics are mainly related to the working conditions (temperature, irradiance). The I-V curves of PV modules under different working conditions are shown in Fig. 1.

There are four characteristics of the output characteristics: open circuit voltage  $V_{oc}$ , short circuit current  $I_{sc}$  as well as the voltage  $V_{mp}$  and current  $I_{mp}$  of the maximum power point (MPP) at the PV array.



**Figure 1:** I-V curve under various operating circumstances: (a) I-V curves at different irradiances; (b) I-V curves at different temperatures

The main types of PV module failures are short circuit, open circuit, partial shading, and degradation faults. Open-circuit faults are caused by disconnected cell connections and physical damage, etc., manifested as  $I_{sc}$  and  $I_{mp}$  equal to 0. The short-circuit fault of the module is caused by the connection of conductive substances between the cells, etc., expressed as  $V_{oc}$  and  $V_{mp}$  equal to 0. When a PV array is partially shaded, it means that the temperature and irradiation it receives from the sun are uneven due to nearby structures, passing clouds, and tall trees, among other factors [18,19]. The bulk of degradation problems may be seen as an increase in the degradation PV array's degradation PV modules' series equivalent resistances [15]. The I-V curves when the partial shading or the degradation faults occur are shown in Figs. 2a and 2b. The above two faults are characterized by a decrease in  $V_{mp}$  and  $I_{mp}$ , and a no change in  $V_{oc}$  and  $I_{sc}$ .



Figure 2: I-V curves under different faults: (a) partial shadowing faults; (b) degradation faults

EE, 2024, vol.121, no.3

For the above faults, open circuit faults can be accurately determined by whether  $I_{sc}$  and  $I_{mp}$  are equivalent to 0. Short circuit faults can be accurately determined by whether  $V_{oc}$  and  $V_{mp}$  are equivalent to 0. Under other faults,  $V_{oc}$  and  $I_{sc}$  behave just as they would in a normal situation. So, they can determine the present working conditions if they are not equal for all working situations at once. Also, if  $V_{oc}$  and  $I_{sc}$  are determined,  $V_{mp}$  and  $I_{mp}$  are also uniquely determined during normal operation. If the corresponding  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  under different working conditions are calculated in advance, the array of I-V features under the corresponding working conditions can be formed. When the PV module is operating, if there is an array that matches all four measured features, it can be judged to be operating normally. If  $V_{oc}$  and  $I_{sc}$  match an array's corresponding values, the present working condition matches to the feature array's correspondence condition. In addition, the presence of partial shadowing or aging faults is indicated when  $V_{mp}$  and  $I_{mp}$  are less than the corresponding values in the feature array.

However, according to Fig. 1, there may be equal correspondence between  $V_{oc}$  and  $I_{sc}$  for different operating conditions. Therefore, if the current working conditions are to be judged by them, a proof is required.

Irradiance and temperature relationships, as well as those between  $V_{oc}$  and  $I_{sc}$ , are depicted in Eqs. (1) and (2), respectively [20].

$$I_{\rm sc} = \frac{G}{G_{\rm stc}} \left[ I_{sc,stc} + \mu_{I_{sc}} \left( T - T_{stc} \right) \right] \tag{1}$$

$$V_{oc} = V_{oc,stc} + \frac{N_{s}kT}{q}\ln(G) + \mu_{V_{oc}}(T - T_{stc})$$
<sup>(2)</sup>

where,  $\mu_{V_{oc}}$  and  $\mu_{I_{sc}}$  is the thermal coefficient of the  $V_{oc}$  and  $I_{sc}$ . Assuming that the  $V_{oc}$ ,  $I_{sc}$  at  $G_1$  and  $\alpha$  are equal to those at  $G_2$  and  $\beta$ , then:

$$\frac{G_1}{G_2} = \frac{\mu_{I_{sc}} \left(\beta - \alpha\right)}{\left[I_{sc,stc} + \mu_{I_{sc}} \left(\alpha - T_{stc}\right)\right]} + 1 \tag{3}$$

$$\frac{N_{s}kT_{2}}{q}\ln\left(\frac{G_{1}}{G_{2}}\right) = \left[\mu_{V_{oc}} + \frac{N_{s}k}{q}\ln\left(G_{1}\right)\right](\beta - \alpha)$$
(4)

Since  $\mu_{I_{sc}} (T_1 - T_{stc}) \ll I_{sc,stc}$ , Eqs. (3) and (4) can be simplified to:

$$\ln\left(\frac{\mu_{I_{sc}}\Delta T}{I_{sc}}+1\right) = \frac{\Delta T}{T_2} \left[\frac{q\mu_{V_{oc}}}{N_s k} + \ln\left(G_1\right)\right]$$
(5)

When  $\Delta T > 0$ , there must exist  $G_1$  so that  $\ln (G_1) > -q\mu_{V_{oc}}/N_s k$ , which can be written as  $\ln (G_1) > -q\mu'_{V_{oc}}/k$ , in which  $\mu'_{V_{oc}}$  is the thermal coefficient of the  $V_{oc}$  of a single solar cell:

$$\mu'_{V_{\rm oc}} = \frac{\mu_{V_{\rm oc}}}{N_s} \tag{6}$$

In reference [21], the thermal coefficient of the  $V_{oc}$  of a variety of commercial PV modules was tested with absolute values greater than 0.28%/°C. Typical open-circuit voltage values for crystalline silicon solar cells are 0.45–0.6 V. Taking conservative values of -0.25%/°C and 0.45 V for the above two coefficients, respectively, gives  $\mu'_{Voc}$  as -1.125 mV/°C. The minimum value of 440 kW/m<sup>2</sup> is obtained by applying Eq. (5), which is much higher than the actual working condition. Similarly, it can be proved that Eq. (5) does not hold when  $\Delta T < 0$ .

In summary, there are no two different sets of temperatures and irradiances that make  $V_{oc}$  and  $I_{sc}$  equal at the same time under actual working conditions. It is shown that  $V_{oc}$  and  $I_{sc}$  can determine the current working condition of the PV module and the proposed fault monitoring principle can be implemented.

# **3** Fault Monitoring Methods

According to Chapter 2, the specific implementation process of the fault monitoring method is:

(1) To obtain  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  for different operating conditions during normal operation, forming a theoretical feature library;

(2) Monitor open-circuit, short-circuit, aging, and shadow-obscuring faults online through the theoretical feature library and fault features.

#### 3.1 Theoretical Feature Library Solving

The panel parameters of PV modules are generally  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  under standard operating conditions and the thermal coefficient of the  $V_{oc}$  and  $I_{sc}$ . It is difficult to accurately solve the four characteristic quantities under other operating conditions by these parameters, so the above parameters need to be transformed into PV module model parameters. Among the existing PV module models, the single diode model is widely used in practical engineering because of its simple model and accurate accuracy. The output equation of the single diode model is:

$$I = I_{pv} - I_0 \left[ \exp\left(\frac{(V + IR_s)}{V_t n}\right) - 1 \right] - \frac{V + IR_s}{R_p}$$

$$\tag{7}$$

where  $V_t = N_s kT/q$  is the thermal voltage of the array with  $N_s$  cells connected in series.  $q = 1.602 \times 10^{-19}$  is the electron charge;  $k = 1.381 \times 10^{-23}$  is the Boltzmann constant; T is the PV module temperature; n,  $I_{pv}$ ,  $I_0$ ,  $R_s$ ,  $R_p$  are respectively diode ideality factor, photocurrent, diode saturation current, series resistance, and shunt resistance.

Under different working conditions, series resistance remains essentially the same. The photocurrent and diode saturation current are given by:

$$I_{\rm ph} = \frac{G}{G_{\rm ref}} \cdot \left[ I_{\rm ph,ref} + \mu_{I_{\rm SC}} \cdot (T - T_{\rm ref}) \right]$$

$$I_0 = I_{0,\rm ref} \cdot \left( \frac{T}{T_{\rm ref}} \right)^3 \cdot e^{\left[ \frac{q \cdot e_G}{\gamma \cdot k} \cdot \left( \frac{1}{T_{\rm ref}} - \frac{1}{T} \right) \right]}$$
(8)
(9)

where  $\varepsilon_{G}$  is the energy bandgap. The shunt resistance is given by:

$$R_{p} = R_{p,\text{base}} + \left(R_{p,0} - R_{p,\text{base}}\right) \cdot e^{-R_{p,\text{exp}} \cdot \left(\frac{G}{G_{\text{ref}}}\right)}$$
(10)

where

$$R_{p,\text{base}} = \max\left[\left(\frac{R_{p,\text{ref}} - R_{p,0} \cdot e^{-R_{p,\text{exp}}}}{1 - e^{-R_{p,\text{exp}}}}\right), 0\right]$$
(11)

where  $R_{p,exp}$  and  $R_{p,0}$  were calculated according to reference [22]. The diode ideality factor is given by:  $n(T) = n_{ref} + \mu_n \cdot (T - T_{ref})$ (12)

where  $\mu_n$  is the temperature coefficient of *n*.

#### EE, 2024, vol.121, no.3

According to reference [23], using the factory parameters of the PV module, the five parameters  $n_{\text{ref}}$ ,  $I_{\text{pv,ref}}$ ,  $R_{\text{s,ref}}$  and  $R_{\text{p,ref}}$  under standard operating conditions can be obtained by iterative calculation. The five parameters under different working conditions can be calculated by Eqs. (8)-(12). According to the single diode model, the explicit expressions for the output voltage and current of the solar cell are obtained by the Lambert W function:

$$V = -IR_s - IR_p + I_{ph}R_p - V_t n \text{Lambert} W(Z) + I_0 R_p$$
(13)

$$I = \frac{R_{\rm p} \left(I_{\rm ph} + I_{\rm s}\right) - V}{R_{\rm s} + R_{\rm p}} - \frac{V_{\rm t} n}{R_{\rm s}} W[Y]$$
(14)

where

$$Z = \frac{R_{\rm p}I_0}{V_{\iota}n} \exp\left(\frac{R_{\rm p}\left(I_{\rm ph} + I_0 - I\right)}{V_{\iota}n}\right)$$
(15)

$$Y = \frac{R_{\rm s}R_{\rm p}I_{\rm s}}{V_{\rm t}n\left(R_{\rm s}+R_{\rm p}\right)}\exp\left[R_{\rm s}R_{\rm p}\left(I_{\rm ph}+I_{\rm s}\right) + \frac{R_{\rm p}V}{V_{\rm t}n\left(R_{\rm s}+R_{\rm p}\right)}\right]$$
(16)

Let I and V in Eqs. (15) and (16) equal 0, respectively,  $V_{oc}$  and  $I_{sc}$  are given by:

$$V_{oc} = I_{ph}R_p - V_t n \text{Lambert} W(Z) + I_0 R_p$$
(17)

$$I_{sc} = \frac{R_{\rm p} \left( I_{\rm ph} + I_{\rm s} \right)}{R_{\rm s} + R_{\rm p}} - \frac{V_{\prime} n}{R_{\rm s}} W[Y]$$
(18)

Similarly, the PV module output power is expressed by output current and output voltage, respectively, as:

$$P(I) = I\left(-IR_{\rm s} - IR_{\rm p} + I_{\rm ph}R_{\rm p} - V_{\rm i}n\text{Lambert }W(Z) + I_{\rm o}R_{\rm p}\right)$$
<sup>(19)</sup>

$$P(V) = \frac{V\left[-VR_{\rm s} - \text{Lambert } W(Y) V_{\rm t} n \left(R_{\rm p} + R_{\rm s}\right) + R_{\rm s} I_{\rm ph} R_{\rm p} + R_{\rm s} I_0 R_{\rm p}\right]}{R_{\rm s} \left(R_{\rm p} + R_{\rm s}\right)}$$
(20)

Derive Eqs. (19) and (20), respectively, and make the derivative equal to 0.  $I_{mp}$  and  $V_{mp}$  are given by:

$$\left(\frac{\partial P}{\partial I}\right)\Big|_{I=I_{mp}} = 0 = -IR_s - IR_p + I_{ph}R_p - V_t n \text{LambertW}(Z) + I_0R_p + I\left(-R_s - R_p + \frac{\text{LambertW}(Z)}{1 + \text{LambertW}(Z)}\right)$$
(21)

$$\left(\frac{\partial P}{\partial V}\right)\Big|_{V=V_{mp}} = 0 = -\frac{V}{R_s + R_p} - \frac{V_{ln} \text{LambertW}(Y)}{R_s} + \frac{R_p \left(I_{ph} + I_0\right)}{R_s + R_p} + V\left(-\frac{1}{R_s + R_p} - \frac{\text{LambertW}(Y) R_p}{(1 + \text{LambertW}(Y)) \left(R_s + R_p\right) R_s}\right)$$
(22)

According to the method described in this section, the feature arrays of PV cells at different temperatures and irradiances are obtained to form a theoretical feature library.

#### 3.2 Fault Monitoring Process

This study only takes into consideration scenarios where the photovoltaic modules within the string have the same model and have been in use for the same duration. Due to the fact that the aging of photovoltaic modules is mainly related to humidity and altitude, only the entire string is considered to undergo the same degree of aging [24]. For shadowing faults, there may be situations where some modules experience shadowing or all modules experience shadow blocking. The likelihood of the occurrence of faults in which all modules within a string experience failure due to the open circuit or short circuit is extremely low. Therefore, the consideration is solely focused on scenarios where only a fraction of components experience open circuit or short circuit faults. In conclusion, there are five types of faults at the string level: shadowing faults of partial modules; Shadowing faults of all modules; Aging faults of all modules; Short circuit faults of partial modules.

When a short circuit fault occurs in partial modules, the open circuit voltage of those modules is 0. When an open circuit fault occurs in partial modules, the short circuit current of the entire string is 0.

According to Section 2, the open-circuit and short-circuit fault characteristics are more obvious, so the presence of these two faults is first accurately determined. Considering the error of the measuring instrument and the minimum values of  $I_{sc,e}$  and  $V_{oc,e}$  in the theoretical feature library, the open-circuit fault monitoring threshold for  $I_{sc}$  is set as:

$$I_{\min} = 0.05A$$
 (23)

The short-circuit fault monitoring threshold for  $V_{oc}$  is set as:

$$V_{\min} = 0.1 V$$
 (24)

If the measured  $I_{sc}$  of the PV string is lower than  $I_{min}$ , it means there is an open circuit fault of partial modules; if the measured  $V_{oc}$  of some modules is lower than  $V_{min}$ , it means that those modules have a short circuit fault.

When a shadowing fault of partial modules occurs, at the maximum power point, due to the photovoltaic modules being connected in series, the current through each module is equal at this time. The maximum power point voltage of the shaded module will be lower than that of the other modules. By monitoring the  $V_{mp}$  of each module of the photovoltaic string and comparing them with each other, it can be determined whether there is a shadowing fault of partial modules.

After excluding the short circuit fault of partial modules, open circuit fault of partial modules, and shadowing faults of partial modules, The open circuit voltage and short circuit current of each photovoltaic module in the photovoltaic string are equal. Through Section 2, it can be proven that the operating conditions of each module of the photovoltaic string are the same at this time, so analysis can be conducted on the data of a single module. On the basis of the obtained theoretical feature library, the data pairs consisting of open-circuit voltage and short-circuit current from the actual measured data are compared with the theoretical feature library to determine the feature array with the smallest deviation. The operating conditions, i.e., temperature and irradiance, under which this array is located are closest to the current operating conditions. Under normal operating conditions, the measured  $V_{mp}$  and  $I_{mp}$  should match those in this feature array.

According to IEC61724, the error values for current, voltage, and power during measurement are 1% and 2%, respectively. Definition:

$$I_e = | \left( I_{sc,c} - I_{sc,m} \right) \div I_{sc,c} | \tag{25}$$

$$V_e = | \left( V_{oc,c} - V_{oc,m} \right) \div V_{oc,c} | \tag{26}$$

where  $I_{sc,m}$  and  $V_{oc,m}$  are the measured short-circuit current and open-circuit voltage, respectively. The error threshold was set to 2% based on the temperature and irradiance difference and the measurement error for each curve. Iterate through the feature library, calculate the corresponding 1 and 2 in each feature array, and filter out the feature arrays that are both below the error threshold. If it is not present, other faults may happen. For example, when a bypass diode fault occurs, only one of  $V_{oc}$  and  $I_{sc}$  will be changed, and the system reports: no matching IV feature set found, other types of faults occur. When multiple feature arrays are filtered,  $e_r = I_e + V_e$  is calculated separately and compared, and the feature array with the smallest  $e_r$  is selected as the current corresponding feature array.

After determining the characteristic array, it is necessary to distinguish between the occurrence of aging or shadowing faults and normal operation by maximum power point current and voltage. Definition:

$$\Delta = \frac{I_{mp,c} V_{mp,c} - I_{mp,m} V_{mp,m}}{I_{mp,c} V_{mp,c}}$$
(27)

where  $I_{mp,m}$  and  $V_{mp,m}$  are the measured maximum power point current and voltage, respectively. According to IEC61724, the error value of the power generated during the measurement is 2%. According to the definition by most photovoltaic module manufacturers, the normal attenuation rate of photovoltaic modules is 0.5%/year [25]. Use variable time-based parameters as aging fault detection thresholds:

$$\Delta_{\rm max} = (2 + 0.5t)\,\% \tag{28}$$

where t is the operating time of the PV system in years.

Since the power loss due to aging faults is small and often accumulative, while the power loss due to shadowing faults is closely related to the area of shading, the two faults can be distinguished by the range of shading. In this study, the monitoring threshold of shadow shading fault is set at 20% of the shading range. Setting:

$$\Delta_s = 20\% \tag{29}$$

If  $\Delta > \Delta_s$ , the shadowing fault of all modules exists; with  $\Delta_{max} < \Delta < \Delta_s$ , the aging faults of all modules exist.

In summary, the process of online fault monitoring is shown in Fig. 3.

#### 3.3 Monitor System and Experimental Setup

The detection system consists of a photovoltaic system, current and voltage monitoring equipment, controller, signal transmission system, and upper computer. The monitoring of open circuit voltage and short circuit current is carried out by installing voltage monitors at both ends of the photovoltaic module and current monitors at the string end. When conducting fault monitoring, the maximum power point voltage and current under operating status are first transmitted to the upper computer. Then, the system control module controls the string open circuit and transmits the corresponding open circuit voltage of each component to the upper computer. Then, the system control module controls the component short circuit and transmits the corresponding short circuit current of each component to the upper computer. Afterwards, the upper computer analyzes the input data through monitoring algorithms to determine the operational status of the photovoltaic string. The system schematic diagram is shown in Fig. 4.



Figure 3: Online fault monitoring process

The experimental setup used in this study is shown in Fig. 5. The module can monitor the system current and voltage in real time. When the system is stabilizing the output, the module can be used to output  $V_{mp}$  and  $I_{mp}$ . When fault monitoring is required, the controller first disconnects the PV module, waits for the system to stabilize, and reads  $V_{oc}$  of the module. Then, the controller short-circuits the module and reads  $I_{sc}$ .



Figure 4: Monitor system



Figure 5: Experimental setup

# **4** Results and Discussion

The experimental setup was used to monitor the characteristic parameters of the PV modules under four types of faults and under fault-free operation, respectively. In the absence of constant temperature and irradiance equipment, the monitoring was carried out at 8:00 and 14:00 every day in January and June, respectively, in order to cover a large temperature and irradiance range.

# 4.1 Calculation Results of Theoretical Feature Library

The PV module used is M81-400WT and the panel parameters are shown in Table 2.

Since  $V_{oc}$  is mainly related to temperature, the short-circuit current is mainly related to irradiance. The PV module used in this study has an  $V_{oc}$  change of 0.15 V at a temperature change of 1°C and a short-circuit current change of 0.032 A at an irradiance change of 10 W/m<sup>2</sup>. The measurement noise causes errors between the measured and real values. According to IEC61724, the error values generated by current, voltage, and power during measurement are 1%, 1%, and 2%, respectively. Therefore, the temperature difference is taken as 3°C and the irradiance difference is taken as 10 W/m<sup>2</sup> when calculating the characteristic library. Meanwhile, the temperature range was set to 0°C–60°C and the irradiance range was set to 20–1200 W/m<sup>2</sup> according to the ambient temperature and irradiance of the area where the experiment was conducted.

Table 2:	Photovoltai	c module	parameters
----------	-------------	----------	------------

$V_{oc}$	$I_{sc}$	$V_{\scriptscriptstyle mp}$	$I_{mp}$	$P_{\rm max}$	$N_{S}$	
53.1V	9.73A	43.7V	9.16A	400W	72	

According to the method described in 3.1, 2499 sets of feature arrays were obtained to form the theoretical feature library, which is shown in Fig. 6.



Figure 6: Theoretical feature library

## 4.2 Fault-Free Operation

For a given photovoltaic string, under the conditions of using identical photovoltaic modules, the electrical parameters will be the same under normal operation in the same environment. Therefore, an analysis can be conducted using the electrical parameters of a given module.  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  of each experiment in fault-free operation of PV modules are shown in Fig. 7a; The results for each experiment corresponding to  $I_e$ ,  $V_e$  and  $\Delta$  are shown in Fig. 7b.

In all experiments,  $I_e$ ,  $V_e$  and  $\Delta$  were below the corresponding thresholds, which indicates that the method did not cause any misclassification during fault-free operation of the system. Meanwhile, the feature array of the feature library can be localized in all the experiments, which fully demonstrates the accuracy of the computational method of the feature library proposed in the paper.



**Figure 7:** Results of experiments in fault-free operation: (a)  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$ ; (b)  $I_e$ ,  $V_e$  and  $\Delta$ 

## 4.3 Short-Circuit Fault and Open-Circuit Faults Experiments

As stated in chapter 2, when an open-circuit fault of partial modules occurs, the short-circuit current of the entire string drops to 0. When a short-circuit fault of partial modules occurs, the open-circuit voltage of that module is 0 and the open-circuit voltage of the other components is normal. In the experiment, three PV modules were connected in series and the first PV module was shorted and disconnected respectively. Taking a certain day as an example, the corresponding experimental data of the first PV module are shown in Table 3.

Fault type	$V_{oc}\left(V ight)$	$I_{sc}\left(A ight)$
Short-circuit fault	0	7.52
	0	5.34
Open-circuit fault	47.32	0
	39.44	0

Table 3: Open-circuit and short-circuit fault of partial modules experiments

When the open-circuit fault occurs,  $I_{sc} < I_{min}$ ; and when the short-circuit fault occurs,  $V_{oc} < V_{min}$ , which is proved that the method can accurately determine open circuit and short circuit faults. When an open-circuit fault occurs, the current of the whole module will be 0 due to a broken module, and it is difficult to locate the fault at this time, and it is still necessary to locate the faulty module by removing each module and observing the system operation. However, when a short-circuit fault occurs, because the open-circuit voltage of the fault module is 0, it is possible to accurately locate the fault point.

## 4.4 Aging Fault Experiments

Since each module of the PV string is located in the same ambient humidity and altitude, only the modules undergoing the same degree of aging are considered in this paper.

Since the PV system used for the experiment was less than one year, the power detection threshold was set to:

$$\Delta_{\rm max} = (2 + 0.5 \times 1)\% = 2.5\% \tag{30}$$

Aging faults were simulated by connecting the resistors in series. Simulate minor aging faults and severe aging faults by connecting 0.3 and 0.6  $\Omega$  resistors in series, respectively.

 $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  of each experiment in minor aging fault operation of PV modules are shown in Fig. 8a. The results for each experiment corresponding to  $I_e$ ,  $V_e$  and  $\Delta$  are shown in Fig. 8b.



**Figure 8:** Results of experiments in minor aging fault operation: (a)  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$ ; (b)  $I_e$ ,  $V_e$  and  $\Delta$ 

 $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  in severe aging fault operation of PV modules are shown in Fig. 9a. The results for each experiment corresponding to  $I_e$ ,  $V_e$  and  $\Delta$  are shown in Fig. 9b.



**Figure 9:** Results of experiments in severe aging fault operation: (a)  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$ ; (b)  $I_e$ ,  $V_e$  and  $\Delta$ 

When minor aging fault and severe aging fault occurs, the corresponding feature arrays can be located by  $I_e$  and  $V_e$ . The values of  $\Delta$  range from 2% to 10% for minor aging and from 8% to 14% for severe aging. It is shown that the method proposed in this paper is able to accurately monitor aging faults.

# 4.5 Shadowing Fault Experiments

In this study, shadowing faults are simulated by shading 40% and 60% of the PV module, respectively.

Connect the three modules in series to form a group string. In the event of a shadow masking fault of the same magnitude in all three modules, each electrical parameter of the three modules is equal at that time, so the data from a single module is used to analyze the operating status of the string.

 $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  of each experiment in 40% shadowing fault operation of PV modules are shown in Fig. 10a. The results for each experiment corresponding to  $I_e$ ,  $V_e$  and  $\Delta$  are shown in Fig. 10b.



**Figure 10:** Results of experiments in 40% shadowing fault operation: (a)  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$ ; (b)  $I_e$ ,  $V_e$  and  $\Delta$ 

 $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$  of each experiment in 60% shadowing fault operation of PV modules are shown in Fig. 11a; The results for each experiment corresponding to  $I_e$ ,  $V_e$  and  $\Delta$  are shown in Fig. 11b.

When shadowing fault occurs, the corresponding feature arrays can be located by  $I_e$  and  $V_e$ . The values of  $\Delta$  range from 35% to 55% for 40% shadowing and from 55% to 70% for 60% shadowing. It is shown that the method proposed in this paper is able to accurately monitor the shadowing faults of all modules.

Simulating a shadowing fault of partial modules by shadow masking the first module. The experimental data are shown in Table 4.

When the partial shading fault occurs on some modules, the maximum power point voltage of the faulty modules is much lower than that of the normally operating modules. Experimental data shows that the method proposed in this paper can accurately locate the faulty modules under partial shading fault conditions.



**Figure 11:** Results of experiments in 60% shadowing fault operation: (a)  $V_{oc}$ ,  $I_{sc}$ ,  $V_{mp}$  and  $I_{mp}$ ; (b)  $I_e$ ,  $V_e$  and  $\Delta$ 

Fault type	No. of experiments	$V_{mp}\left(V ight)$		
		First module	Second module	Third module
	1	38.26	49.13	49.13
60% Shadowing	2	39.80	51.59	51.59
	3	38.91	50.07	50.07
	1	39.89	50.30	50.30
40% Shadowing	2	39.96	48.51	48.51
	3	38.46	46.52	46.52

Table 4: Shadowing fault of partial modules experiments

# **5** Conclusions

This paper proposes a novel real-time data-based monitoring method. This approach enables the monitoring of module or string-level photovoltaic systems solely through the analysis of electrical signals. In contrast to other methods, this approach only requires monitoring the open-circuit voltage, short-circuit current, and voltage and current at the maximum power point, without the need for environmental parameter monitoring. The experimental validation of the fault monitoring method proposed in this paper is carried out by the M81-400WT PV module. Experiments were conducted on PV modules in normal operation, aging failure, shadow shading failure, open circuit failure, and short circuit failure, respectively. The experiments prove that the method proposed in this paper does not misjudge during normal operation, and can determine open-circuit faults, short-circuit faults, aging faults, and shadow shading faults with shading area greater than 20%. which demonstrates the effectiveness of the method proposed in this paper. This method overcomes the disadvantage that the historical data-based method requires a large amount of experimental data to be obtained for effective monitoring, which makes it more suitable for diverse distributed PV scenarios. The method eliminates

the mistakes generated by the aforementioned sensors and increases the precision of fault monitoring by doing away with the requirement for temperature and irradiance sensors from prior real-time databased techniques. Additionally, it reduces the system cost for the two sensors mentioned above.

The shortcoming of this paper is that the feature array calculated based on the Lambert W function and iterative method has some inherent errors. To further increase the monitoring accuracy, we intend to develop a better calculating approach to produce a theoretical feature library with more precision. Meanwhile, the fault monitoring method proposed in this study is temporarily unable to classify aging faults and shadowing faults with a shadowing area of less than 20 percent. To be able to further classify the two faults, it is suggested that future research implement the function of extracting the peak number of the IV curve in the controller. Finally, this study is temporarily unable to monitor faults that do not affect the PV module output characteristics, such as rain ground faults, a type of fault that would be considered to be operating the module normally under existing monitoring methods. This type of fault will be analyzed separately in further studies to improve the monitoring system.

Acknowledgement: The authors acknowledge the support of CHNG Science and Technology Project (Design and Manufacture of Adaptive, Customized, Localised Autonomous Controllable Wind Turbines, and Remote Sea Power Transmission Technology) and 2023 Tianjin University's "Rural Revitalization" Independent Innovation Fund Project-Online Fault Monitoring Methods and Empirical Research on Roof Photovoltaic Systems.

**Funding Statement:** This paper is supported by CHNG Science and Technology Project (HNKJ20-H54 Design and Manufacture of Adaptive, Customized, Localised Autonomous Controllable Wind Turbines, and Remote Sea Power Transmission Technology). This research is supported by 2023 Tianjin University's "Rural Revitalization" Independent Innovation Fund Project-Online Fault Monitoring Methods and Empirical Research on Roof Photovoltaic Systems.

Author Contributions: The authors confirm contribution to the paper as follows: study conception and design: Huaxing Zhao; data collection: Huaxing Zhao; analysis and interpretation of results: Huaxing Zhao; draft manuscript preparation: Huaxing Zhao, Yanbo Che, Gang Wen, Yijing Chen. All authors reviewed the results and approved the final version of the manuscript.

Availability of Data and Materials: Data supporting this study are included within the article.

**Conflicts of Interest:** The authors declare that they have no conflicts of interest to report regarding the present study.

## References

- 1. Kapucu, C., Cubukcu, M. (2021). A supervised ensemble learning method for fault diagnosis in photovoltaic strings. *Energy*, 227, 120463.
- 2. Guerriero, P., di Napoli, F., Vallone, G., d'Alessandro, V., Daliento, S. (2016). Monitoring and diagnostics of PV Plants by a wireless self-powered sensor for individual panels. *IEEE Journal of Photovoltaics*, 6(1), 286–294.
- 3. Chine, W., Mellit, A., Lughi, V., Malek, A., Sulligoi, G. et al. (2016). A novel fault diagnosis technique for photovoltaic systems based on artificial neural networks. *Renewable Energy*, *90*, 501–512.
- 4. Ando, B., Baglio, S., Pistorio, A., Tina, G. M., Ventura, C. (2015). Sentinella: Smart monitoring of photovoltaic systems at panel level. *IEEE Transactions on Instrumentation & Measurement*, 64(8), 2188–2199.
- 5. Chen, Z., Wu, L., Cheng, S., Lin, P., Wu, Y. et al. (2017). Intelligent fault diagnosis of photovoltaic arrays based on optimized kernel extreme learning machine and I-V characteristics. *Applied Energy*, 204, 912–931.

- 6. Espinosa, A. R., Bressan, M., Giraldo, L. F. (2020). Failure signature classification in solar photovoltaic plants using RGB images and convolutional neural networks. *Renewable Energy*, *162*, 249–256.
- Hichri, A., Hajji, M., Mansouri, M., Abodayeh, K., Bouzrara, K. et al. (2022). Genetic-algorithm-based neural network for fault detection and diagnosis: Application to grid-connected photovoltaic systems. *Sustainability*, 14(17), 10518.
- 8. Voutsinas, S., Karolidis, D., Voyiatzis, I., Samarakou, M. (2022). Development of a multi-output feed-forward neural network for fault detection in photovoltaic systems. *Energy Reports*, *8*, 33–42.
- 9. Ko, S. W., Ju, Y. C., Hwang, H. M., So, J. H., Jung, Y. S. et al. (2017). Electric and thermal characteristics of photovoltaic modules under partial shading and with a damaged bypass diode. *Energy*, *128*, 232–243.
- 10. Bressan, M., El Basri, Y., Galeano, A. G., Alonso, C. (2016). A shadow fault detection method based on the standard error analysis of I-V curves. *Renewable Energy*, *99*, 1181–1190.
- 11. Leva, S., Mussetta, M., Ogliari, E. (2019). PV module fault diagnosis based on microconverters and dayahead forecast. *IEEE Transactions on Industrial Electronics*, 66(5), 3928–3937.
- 12. Ketjoy, N., Thanarak, P., Yaowarat, P. (2022). Case studies on system availability of PVP plants in Thailand. *Energy Reports*, 8, 514–526.
- 13. Gokmen, N., Karatepe, E., Silvestre, S., Celik, B. M., Ortega, P. (2013). An efficient fault diagnosis method for PV systems based on operating voltage-window. *Energy Conversion and Management*, *73*, 350–360.
- 14. Forero, N., Hernandez, J., Gordillo, G. (2006). Development of a monitoring system for a PV solar plant. *Energy Conversion and Management*, 47(15–16), 2329–2336.
- 15. Silvestre, S., Silva, M. A., Chouder, A., Guasch, D., Karatepe, E. (2014). New procedure for fault detection in grid connected PV systems based on the evaluation of current and voltage indicators. *Energy Conversion and Management*, *86*, 241–249.
- 16. Aljafari, B., Madeti, S. R. K., Satpathy, P. R., Thanikanti, S. B., Ayodele, B. V. (2022). Automatic monitoring system for online module-level fault detection in grid-tied photovoltaic plants. *Energies*, 15(20), 7789.
- 17. Pei, T., Hao, X. (2019). A fault detection method for photovoltaic systems based on voltage and current observation and evaluation. *Energies*, 12(9), 1712.
- Li, G. Q., Jin, Y., Akram, M. W., Chen, X., Ji, J. (2018). Application of bio-inspired algorithms in maximum power point tracking for PV systems under partial shading conditions—A review. *Renewable & Sustainable Energy Reviews*, 81, 840–873.
- 19. Ishaque, K., Salam, Z. (2013). A review of maximum power point tracking techniques of PV system for uniform insolation and partial shading condition. *Renewable & Sustainable Energy Reviews, 19,* 475–488.
- 20. Ibrahim, H., Anani, N. (2017). Variations of PV module parameters with irradiance and temperature. *Energy Procedia*, *134*, 276–285.
- 21. Piliougine, M., Oukaja, A., Sidrach-de-Cardona, M., Spagnuolo, G. (2021). Temperature coefficients of degraded crystalline silicon photovoltaic modules at outdoor conditions. *Progress in Photovoltaics*, 29(5), 558–570.
- 22. Mermoud, A., Lejeune, T. (2010). Performance assessment of a simulation model for PV modules of any available technology. 25th European PV Solar Energy Conference, pp. 6–10. Valencia, Spain.
- 23. Batzelis, E. I., Routsolias, I. A., Papathanassiou, S. A. (2014). An explicit PV string model based on the lambert W function and simplified MPP expressions for operation under partial shading. *IEEE Transactions on Sustainable Energy*, 5(1), 301–312.
- 24. Ketjoy, N., Mensin, P., Chamsa-ard, W. (2022). Impacts on insulation resistance of thin film modules: A case study of a flooding of a photovoltaic power plant in Thailand. *PLoS One, 17,* 1–17.
- 25. Sharma, V., Chandel, S. S. (2013). Performance and degradation analysis for long term reliability of solar photovoltaic systems: A review. *Renewable & Sustainable Energy Reviews*, 27, 753–767.